## Notice of References Cited

	Application/Control No. 10/036,663		Applicant(s)/Patent Under Reexamination MUKHERJEE ET AL.		
	Examiner	Art Unit			
	Wenpeng Chen	2624	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,699,457	12-1997	Adar et al.	382/239
	В	US-6,084,636	07-2000	Sugahara et al.	375/240.03
	С	US-6,320,981	11-2001	Yada, Shinichi	382/168
	D	US-5,986,712	11-1999	Peterson et al.	375/240.14
	E	US-5,657,015	08-1997	Nakajima et al.	341/61
	F	US-5,682,204	10-1997	Uz et al.	375/240.15
	G	US-6,094,455	07-2000	Katta, Noboru	375/240.05
	Н	US-6,590,936	07-2003	Kadono, Shinya	375/240.12
	ı	US-6,075,819	06-2000	Saw, Yoo-sok	375/240
	J	US-6,023,297	02-2000	Kobayashi, Mitsugu	375/240.03
	K	US-			
	L	US-			·
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z		-			
	0					
	Ρ					
	Q					
	R					
	S					,
	Т					

## **NON-PATENT DOCUMENTS**

	NOW THE POST OF TH					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.